## Notice of References Cited Application/Control No. 10/564,086 Examiner Nguyen N. Hanh Applicant(s)/Patent Under Reexamination BIAIS, FRANCOIS Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-3,963,950	06-1976	Watanabe et al.	310/54
	В	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Ι	US-			
	. 1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					,
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

	NOTE A PER POSSIBLE TO				
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	>				
	×				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.